

1/38

FIG. 1

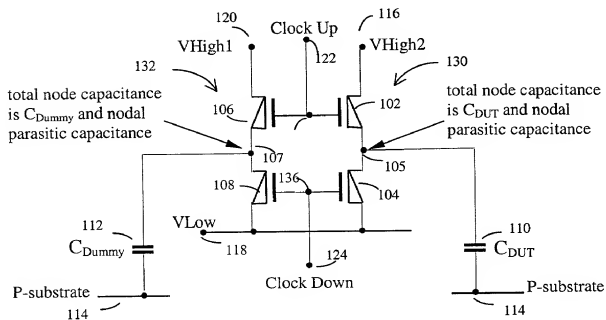


FIG. 2

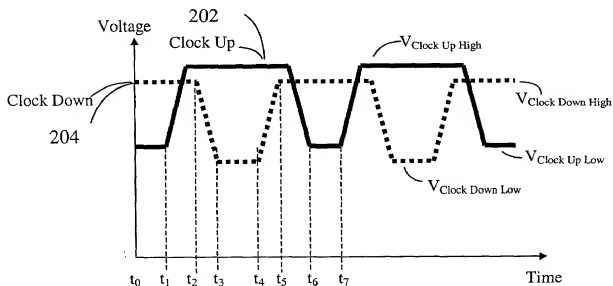


FIG.3

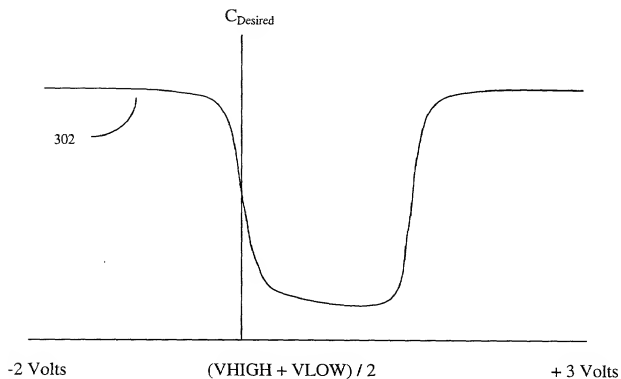
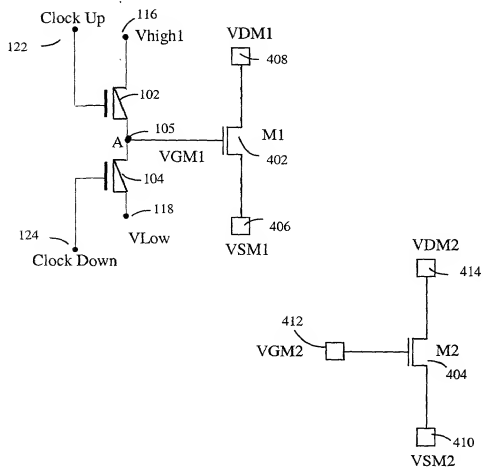


FIG. 4

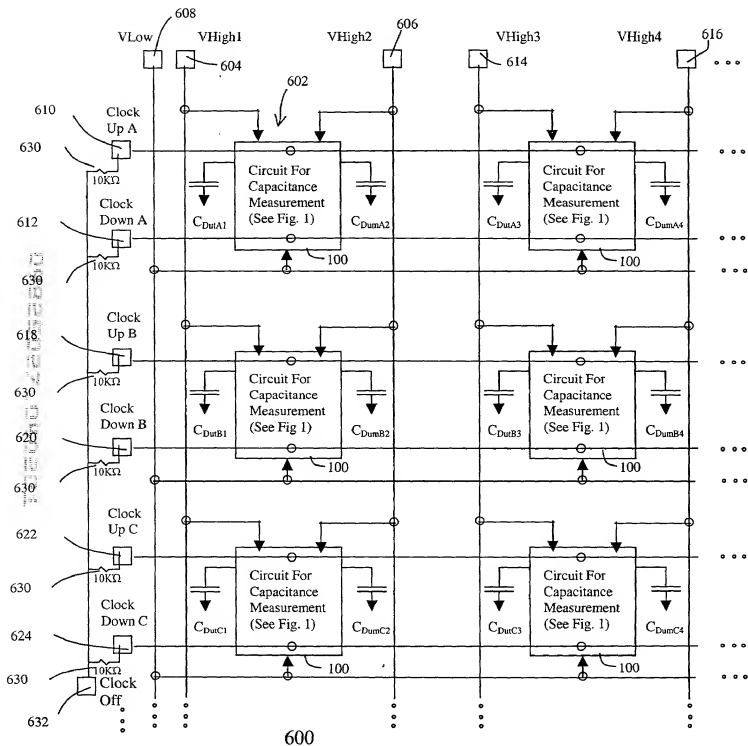




Frequency Divided Down To A Frequency That A Parametric Test System Can Monitor With Standard Measurement Hardware (Relatively Slow).

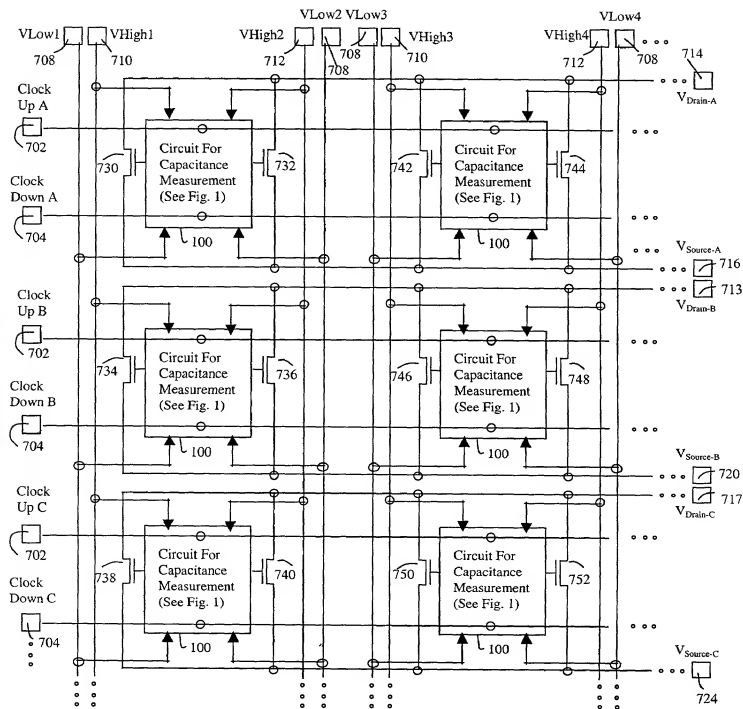
6/38

FIG. 6



7/38

FIG. 7



700

8/38

FIG. 8

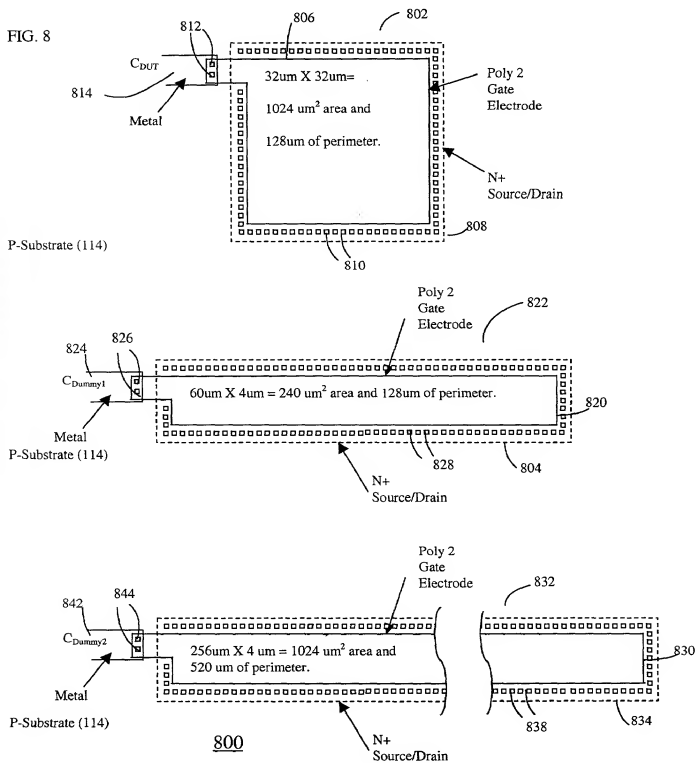
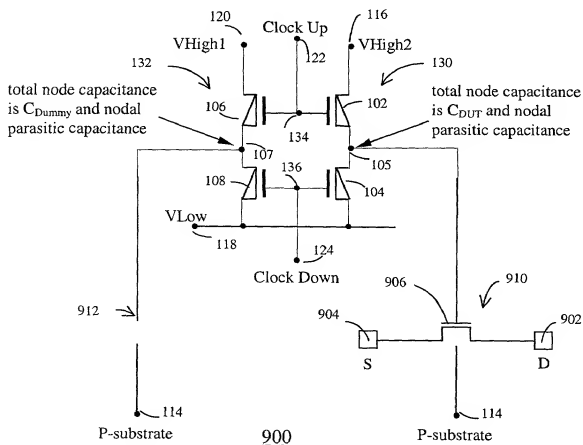


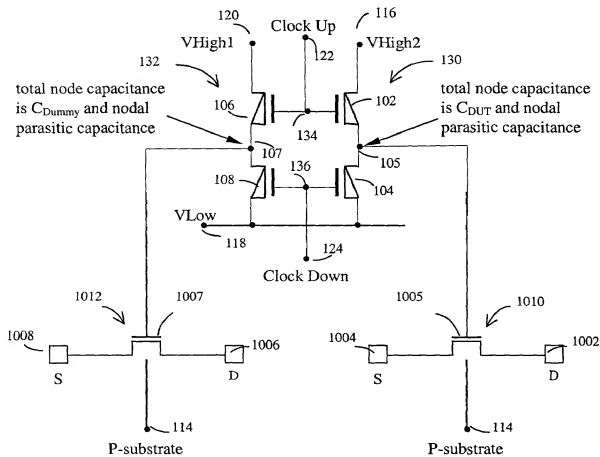


FIG. 9



10/38

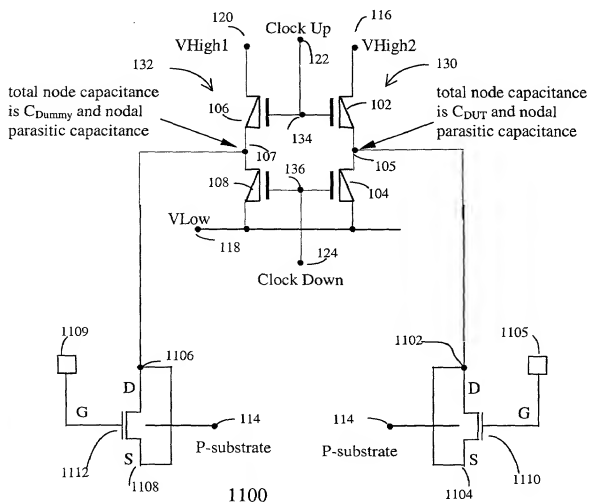
FIG. 10



1000

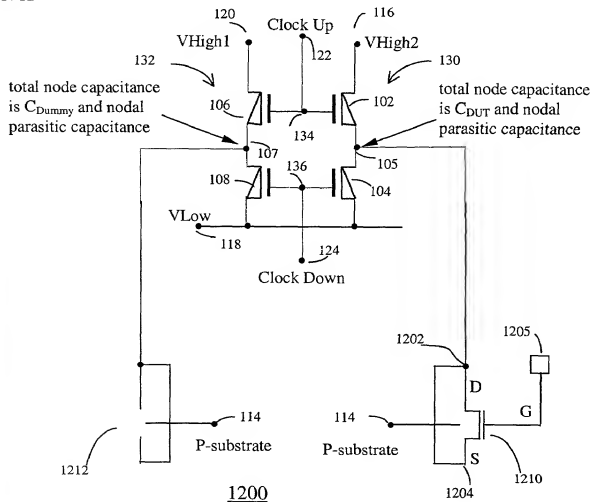
11/38

FIG. 11



12/38

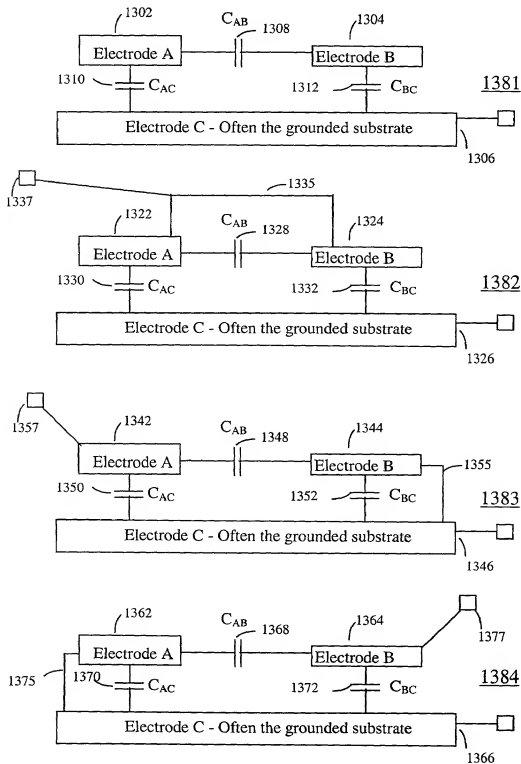
FIG. 12



1200

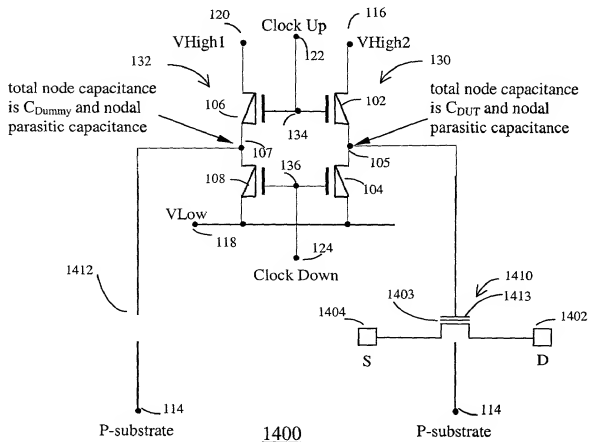
13/38

FIG. 13



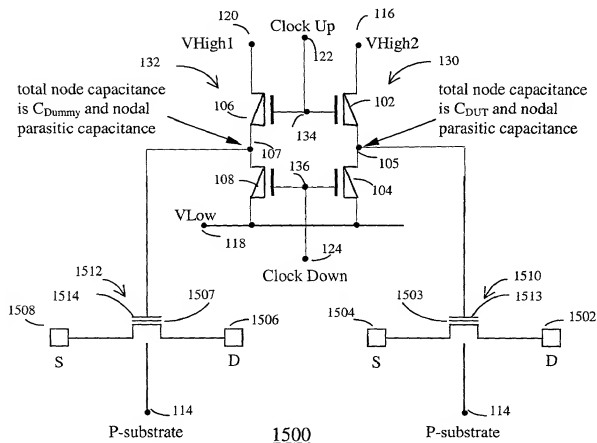
14/38

FIG. 14



15/38

FIG. 15



16/38

FIG. 16

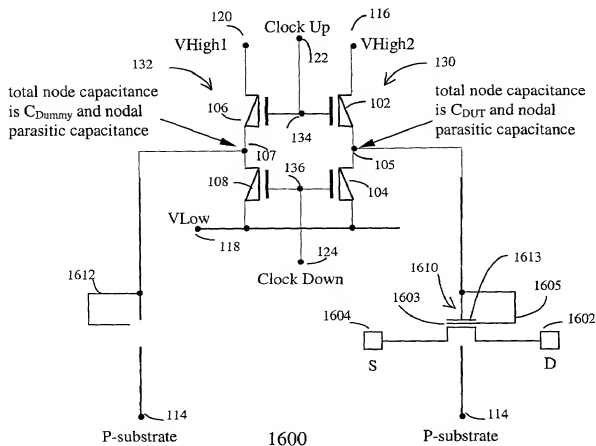
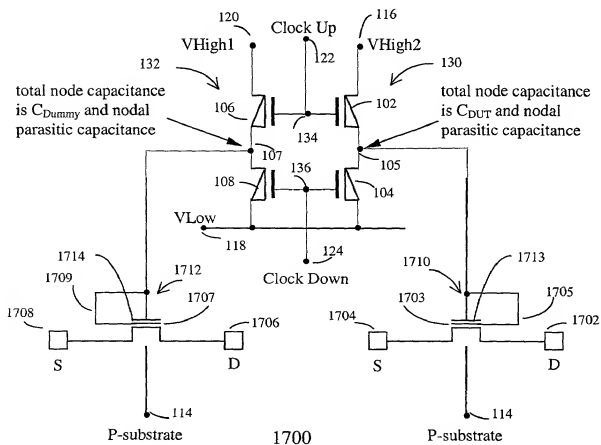


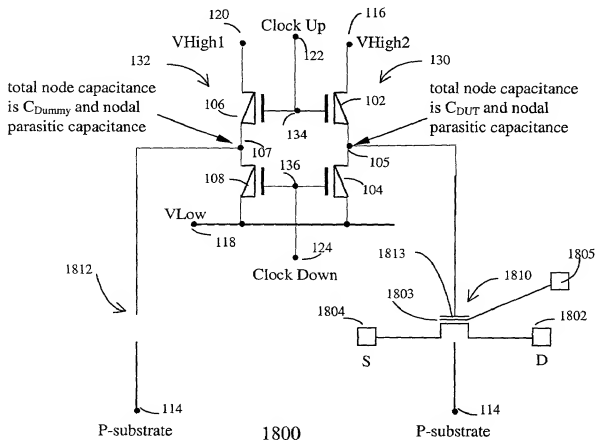


FIG. 17



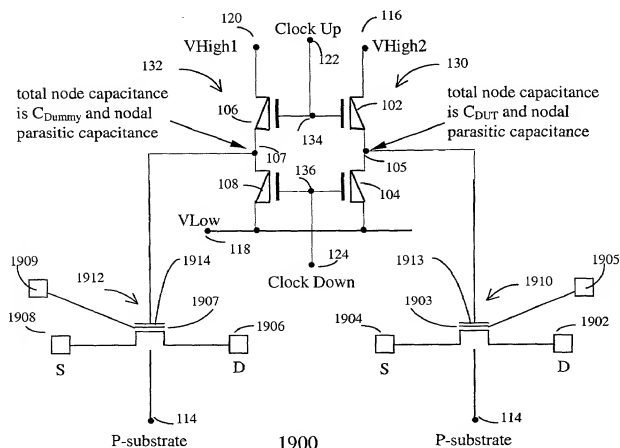
18/38

FIG. 18



19/38

FIG. 19



20/38

FIG. 20

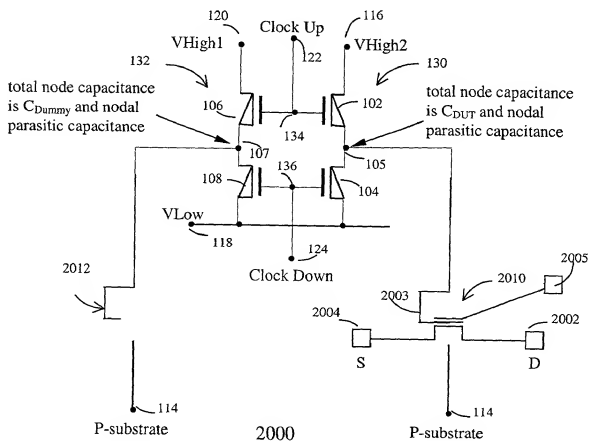
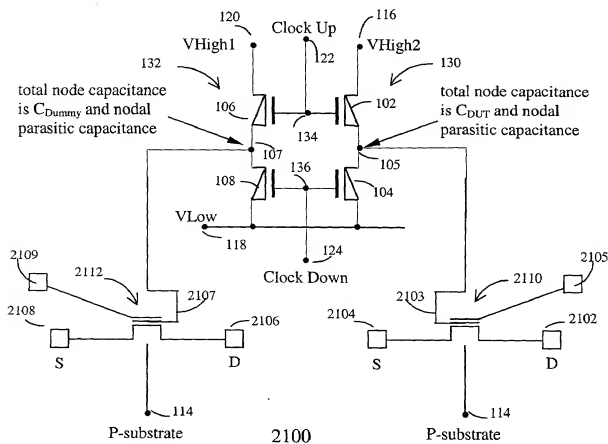
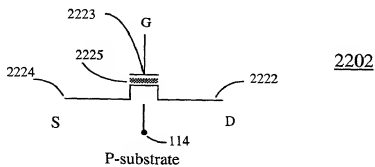
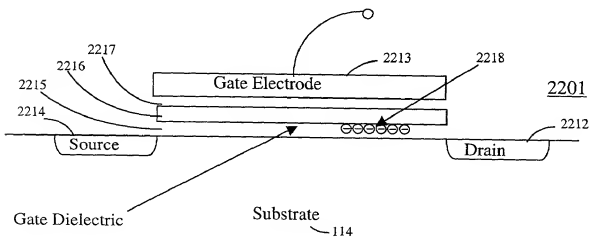
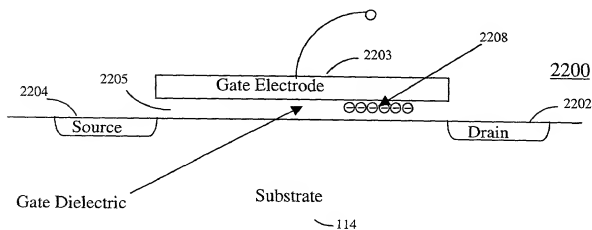


FIG. 21



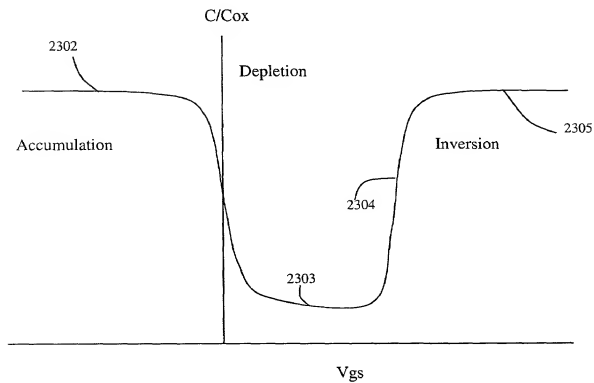
22/38

FIG. 22



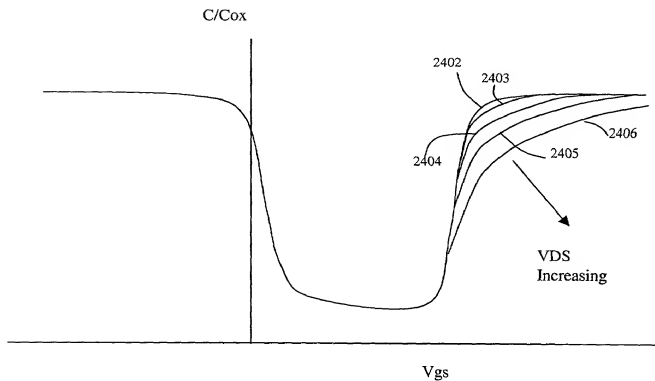
23/38

FIG. 23:



24/38

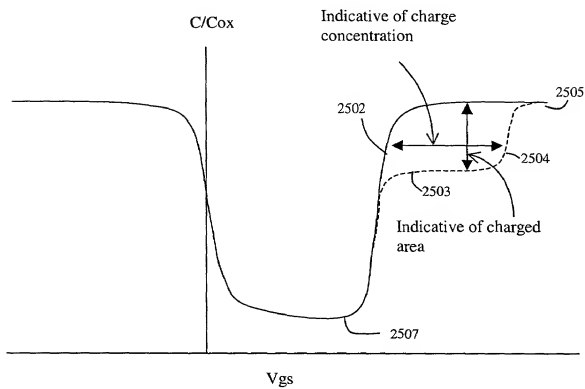
FIG. 24





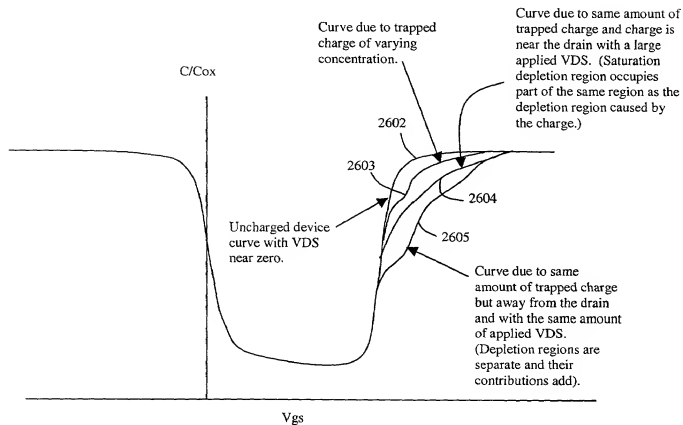
25/38

FIG. 25



26/38

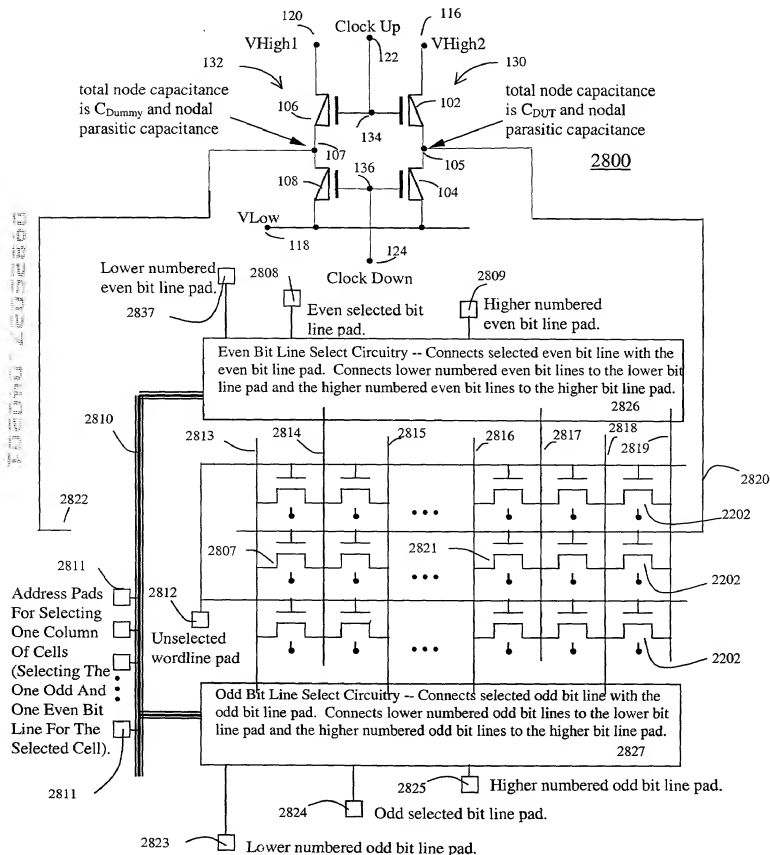
FIG. 26





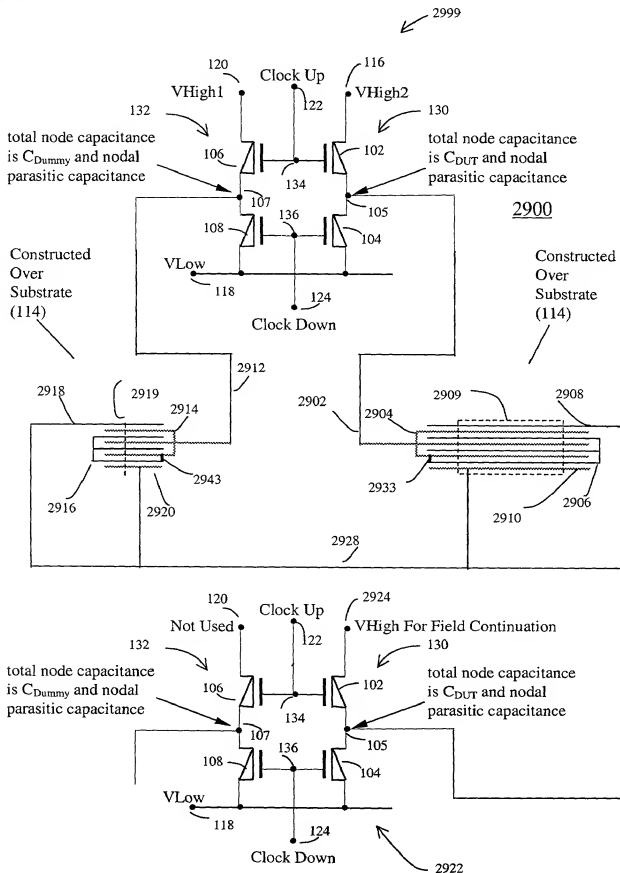
28/38

FIG. 28



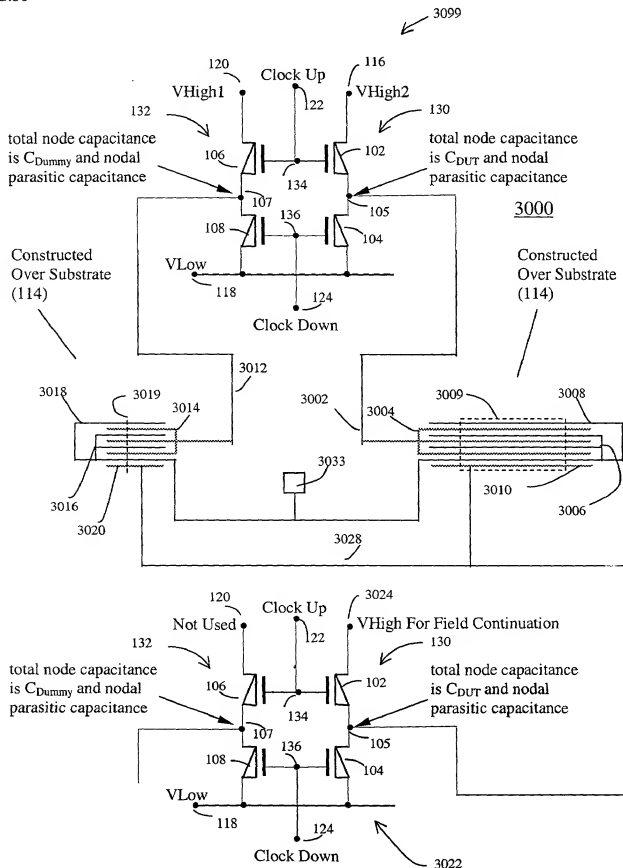
29/38

FIG. 29



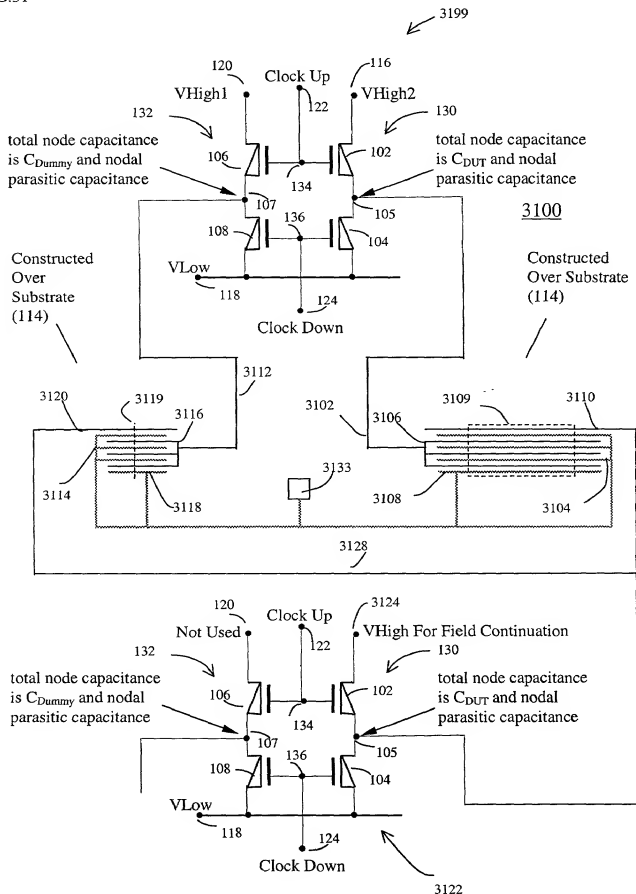
30/38

FIG. 30



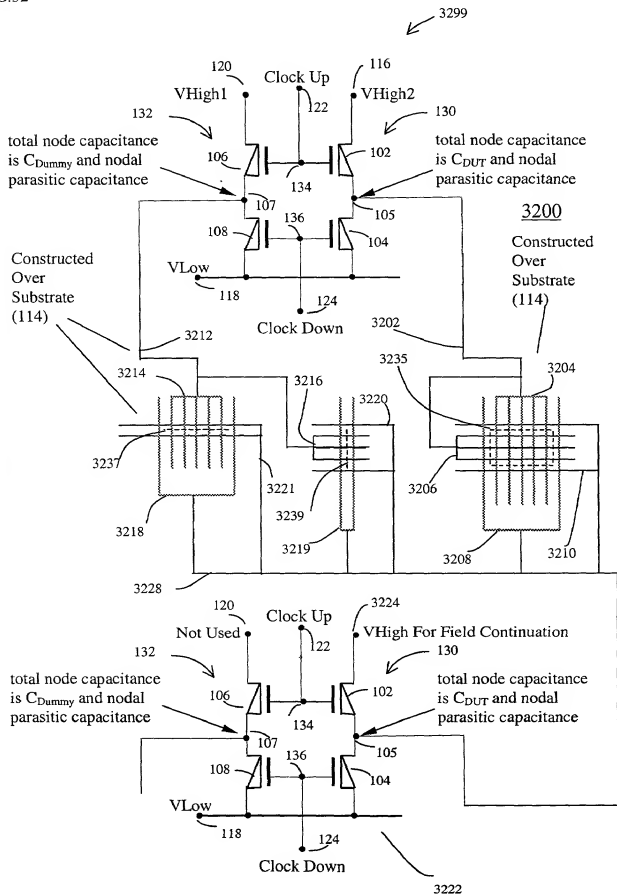
31/38

FIG.31



32/38

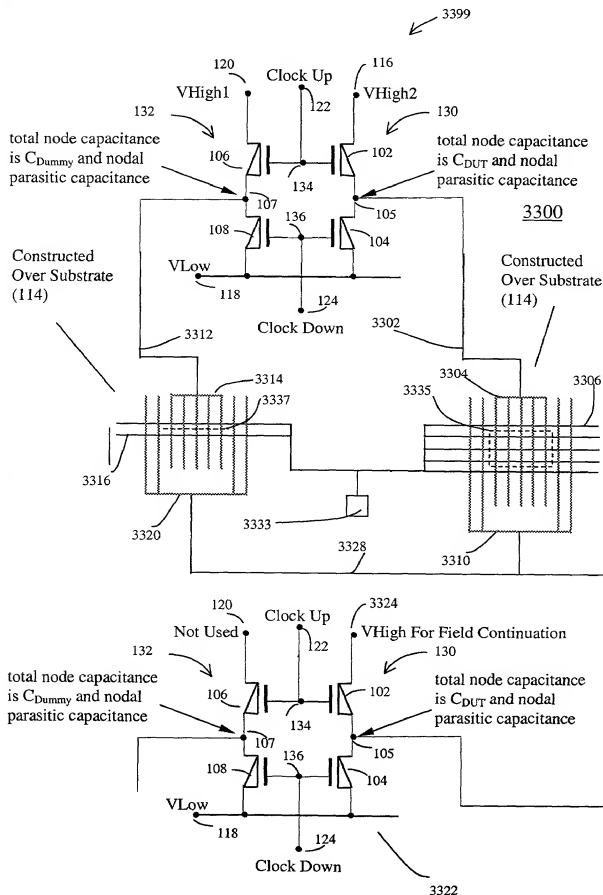
FIG.32

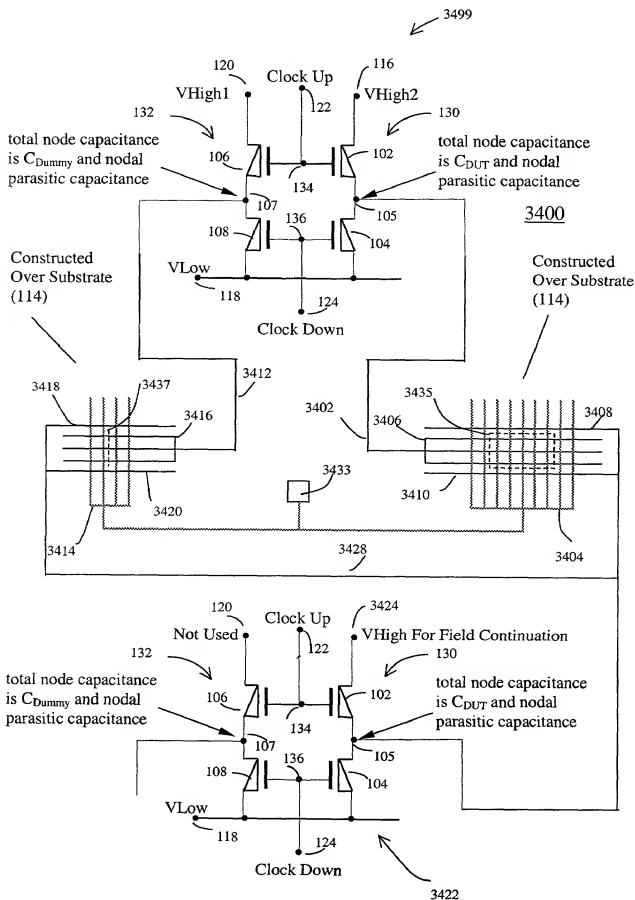




33/38

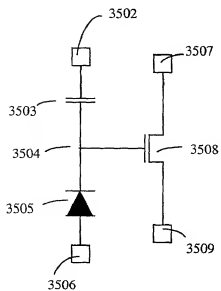
FIG.33



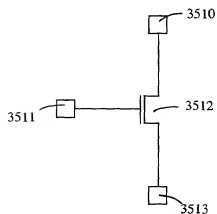


35/38

FIG. 35

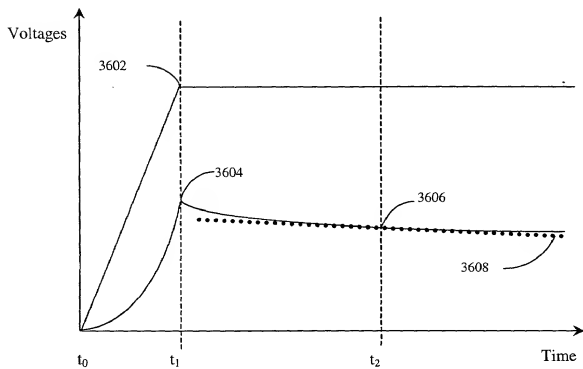


3500



36/38

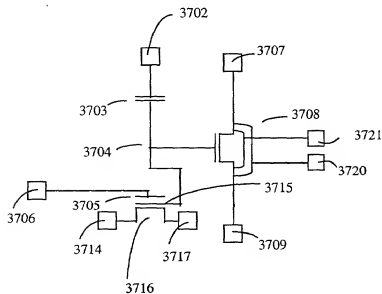
FIG. 36



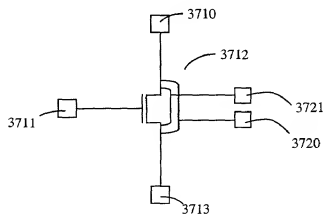
3600

37/38

FIG. 37

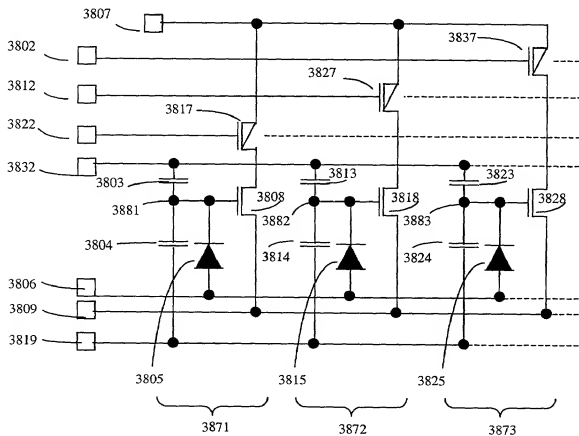


3700



38/38

FIG. 38



3800

